

Terahertz sensing based on the nonlinear electrodynamics of the two-dimensional correlated topological semimetal TaIrTe₄

Tairan Xi¹, Haotian Jiang², Jiangxu Li³, Yangchen He¹, Yuchen Gu², Carter Fox⁴, Louis Primeau³, Yulu Mao², Jack Rollins¹, Takashi Taniguchi⁵, Kenji Watanabe⁶, Daniel van der Weide², Daniel Rhodes^{1,4}, Yang Zhang^{3,7}, Ying Wang^{2,1,4,}, Jun Xiao^{1,2,4,*}*

¹ Department of Materials Science and Engineering, University of Wisconsin-Madison, Madison, Wisconsin 53706, USA

² Department of Electrical and Computer Engineering, University of Wisconsin-Madison, Madison, Wisconsin 53706, USA

³ Department of Physics and Astronomy, University of Tennessee, Tennessee 37996, USA

⁴ Department of Physics, University of Wisconsin-Madison, Madison, Wisconsin 53706, USA

⁵ Research Center for Materials Nanoarchitectonics, National Institute for Materials Science, 1-1 Namiki, Tsukuba, 305-0044, Japan

⁶ Research Center for Electronic and Optical Materials, National Institute for Materials Science, 1-1 Namiki, Tsukuba, 305-0044, Japan

⁷ Department of Electrical Engineering and Computer Science, University of Tennessee, Tennessee 37996, USA

*Corresponding author(s). E-mail(s): jun.xiao@wisc.edu; y.wang@wisc.edu

Abstract

The development of terahertz (THz) sensing technologies is limited by the lack of sensitive, broadband, and fast terahertz detectors. Thermal bolometers are bulky and slow, whereas electronic terahertz detectors (such as Schottky diodes) are fast, but their sensitivity degrades quickly outside a narrow frequency window. Here, we show that a two-dimensional correlated topological semimetal, tantalum iridium telluride (TaIrTe₄), has a large room temperature nonlinear Hall effect, and that the interaction between this effect and terahertz nonlinear electrodynamics can be used as a mechanism for terahertz sensing. Our photodetectors exhibit a high sensitivity (noise equivalent power of around 1 pW Hz^{-1/2}) and a large zero-

bias responsivity (around 0.3 A W^{-1}) a broadband spectral range (0.1–10 THz) at room temperature with intrinsic ultrafast response time (around ps). The zero-bias responsivity and noise equivalent power performance can be further improved (to 18 A W^{-1} and $0.05 \text{ pW Hz}^{-1/2}$, respectively) by introducing gate-tunable electron correlations.

Main

Terahertz (THz) technology is critical to quantum information technology and biomedical sensing because its frequencies (0.1–10 THz) resonate with low-energy collective excitations in quantum materials and molecular vibrations in biological matter. The ultrahigh bandwidth of the THz band could also be used in high-speed wireless communication^{1–4}. However, the widespread adoption of THz technologies has been hindered by the lack of sensitive, broadband, and fast THz detectors^{5–7}. Current primary THz detectors can be classified into two categories^{5,8}: thermal detectors that use THz-induced heating (such as bolometers and Golay cells), and electronic detectors that use THz-driven unidirectional electron flow across junction barriers to achieve nonlinear frequency rectification (such as Schottky diodes). Thermal-type THz detectors are bulky and slow due to thermal heating and transport, with response times on the order of milliseconds. In contrast, electronic rectifiers are compact and can detect nanosecond signal modulation at room temperature, but their responsivity decreases with frequency (less than 100 V W^{-1} or 0.1 A W^{-1} beyond 1 THz)^{9,10}, and they have narrow operating bandwidth ($\sim 0.1 \text{ THz}$) due to intrinsic junction capacitance and resonant tunnelling at the metal-insulator interfaces⁵. It is therefore critical to establish a strong THz light–matter interaction mechanism and develop new material platforms to simultaneously boost responsivity, sensitivity (or noise-equivalent power; NEP), spectral range, and response speed¹¹.

Recently, topological effects in non-centrosymmetric quantum semimetals, such as Weyl semimetals, have been found to cause prominent nonlinear properties^{12,13}. For example, it has been shown that the nonzero quantum geometric property^{14–17} — often referred to as Berry curvature $\Omega_n(k)$ — that occurs in the layered topological semimetal tungsten ditelluride (WTe₂) can lead to a novel nonlinear Hall effect even at room temperature, where longitudinal a.c. driving currents can be rectified into a large transverse d.c. current without invoking any diode or junction region. The underlying mechanism is related to the asymmetric distribution of Berry curvature in momentum space. When an electric field is applied, electrons in the material redistribute in momentum space, leading to an imbalance in the Berry curvature experienced by the electrons. This imbalance gives electrons an anomalous transverse velocity (proportional to the product of the Berry curvature imbalance and the applied electric field), thus leading to a d.c. rectification current^{18,19}. Due to their divergent Berry curvature and asymmetric scattering, the second

order nonlinear susceptibility χ_{abc} of topological semimetals are several orders of magnitude higher ($\sim 10^{-6}$ - 10^{-1} m V $^{-1}$)^{20,21} than that in typical nonlinear optical materials such as LiNbO $_3$ ($\sim 10^{-10}$ - 10^{-9} m V $^{-1}$)^{22,23}, providing highly efficient frequency conversion. These findings at ultra-low frequency (ULF; < 3 kHz) highlight the critical role of quantum geometrical properties and corresponding band structure engineering in enabling new rectification mechanisms. If this junction-free mechanism can be extended to the THz regime²⁴, it could bypass junction-induced performance limitations in existing electronic THz detectors. Gapless and conducting semimetals also intrinsically support broadband and fast photodetection.

In this Article, we report a zero-bias and junction-free THz rectification driven by an intrinsic large Berry curvature dipole (BCD) in few-layer tantalum iridium telluride (TaIrTe $_4$), a non-centrosymmetric 2D correlated topological semimetal. We first examine the THz electrodynamics in atomically thin TaIrTe $_4$ via nonlinear Hall transport measurements and demonstrate a large nonlinear Hall effect. This is then used to develop a THz rectification method that differs from previous bulk centrosymmetric semimetals^{25,26}. We show that a THz photodetector using this mechanism can offer a fast response (\sim ps), high sensitivity (NEP \sim 1 pW Hz $^{-1/2}$) and a large room-temperature responsivity (R \sim 0.3 A W $^{-1}$). We also find that strong electron correlation in the 2D limit leads to substantial band renormalization and can further boost responsivity (R \sim 18 A W $^{-1}$) and sensitivity (NEP \sim 0.05 pW Hz $^{-1/2}$). The electron correlation and THz rectification performance can be modulated by in situ electrostatic gating due to the weak dielectric screening at the few-layer limit.

Large room-temperature nonlinear Hall effect in atomically thin TaIrTe $_4$

TaIrTe $_4$ crystallizes in an orthorhombic structure that belongs to the space group Pmn2 $_1$. Each monolayer of TaIrTe $_4$ comprises a layer of Ta (or Ir) atoms sandwiched between two layers of Te atoms in a distorted octahedral coordination. Because TaIrTe $_4$ is formed by stacking these monolayers with alternating layers rotated by 180 degrees, inversion symmetry is broken. Bulk TaIrTe $_4$ is recognized as a type-II Weyl semimetal with nontrivial Berry curvature monopoles²⁷. Thinning down to few-layer limit (Fig. 1a), its space group changes to Pm due to the lack of the screw-axis and glide-plane symmetries at the surfaces. This symmetry change is critical for enabling the nontrivial Hall effect via in-plane driving electric field, which also has been observed in isostructural WTe $_2$ ^{21,28,29}. In our study, we obtained ultrathin TaIrTe $_4$ flakes by mechanical exfoliation and dry transfer to target SiO $_2$ /Si substrates with thin h-BN capping (see Methods and Supplementary Section 1 and 2). To confirm the change from Pmn2 $_1$ to Pm, we have conducted polarization-resolved SHG and observe a two-fold pattern with minor lobes. This fits well with the nonlinear susceptibility of the Pm space group (Fig. 1b, see Supplementary Section 3). Based on the Boltzmann equation and the anomalous motion equation of Bloch electrons^{18,19}, the nonlinear Hall

rectification current density can be expressed as $J_a(\omega = 0) = \left(\frac{1}{1+\omega^2\tau^2}\right)\chi_{abc}E_b(\omega)E_c(-\omega)$. Here χ_{abc} is nonlinear conductivity tensor, $E_b(\omega), E_c(-\omega)$ are alternating electric field at angular frequency ω (E_b equals to E_c for single AC input) and τ is the average scattering time. It is proportional to the product of nonlinear conductivity tensor χ_{abc} at DC limit and a frequency dependent factor $\tau/(1+\omega^2\tau^2)$. Furthermore, χ_{abc} is directly related to Berry curvature $\Omega_n(k)$ in the following expression: $\chi_{abc} = e^3\tau \int_k (\partial_b f_0) \Omega_n(k) = -e^3\tau \int_k (f_0) \partial_b \Omega_n(k)$, f_0 is the equilibrium electron distribution. To understand the subsequent THz rectification results, it is essential to first examine the nonlinear conductivity at DC limit. Accordingly, we have conducted nonlinear Hall transport measurements in a few-layer sample with Hall bar device geometry at room temperature (Fig. 1c inset), which can probe the nonlinear conductivity around the Fermi level. In particular, we use an AC driving current (I^ω) at 500 Hz applied along the a axis and measure the generated NHE voltage ($V^{2\omega}$) along the b axis. The $V^{2\omega}$ shows quadratic dependence of input I_{AC} (Fig. 1c), which is a hallmark of the NHE effect. Moreover, the NHE generation efficiency $\eta_{ab} = \frac{V_{ab}^{2\omega}}{(V_{aa}^\omega)^2}$ and nonlinear Hall conductivity χ_{baa} are found to be significant, where a and b represent directions along which voltages are applied and measured. For the measured bilayer TaIrTe₄, its χ_{baa} can reach to $\sim 6.6 \times 10^{-2} \mu\text{m V}^{-1} \Omega^{-1}$ at room temperature (See Supplementary Section 4). This value is more than three orders of magnitude larger than that in previous transport study on thick TaIrTe₄ flakes ($> 20 \text{ nm}$)³⁰. On one hand, the lower symmetry at ultrathin limit enables intrinsic Berry curvature contribution which are not present in bulk limit. On the other hand, our DFT and model calculation suggests strongly hybridized Te-p and Ta or Ir-d orbitals near the Fermi level in TaIrTe₄, leading to a nontrivial Berry curvature dipole and corresponding large nonlinear Hall effect (Fig. 1d, and Supplementary section 5).

High-performance Room-temperature THz sensing mediated by nonlinear Hall effect

Building upon the large NHE in few-layer TaIrTe₄, we now interrogate the interplay of NHE with THz electrodynamics as a new mechanism for THz sensing (Fig. 2a). To implement THz sensing, we designed and fabricated atomically thin TaIrTe₄ THz photodetectors in contact with a pair of Cr/Au pre-patterned electrodes and a bow-tie antenna (Fig. 2b inset). Specifically, the antenna is positioned along the a axis of TaIrTe₄, while two electrode contacts are aligned along the b axis for collecting the corresponding rectified current via NHE. To benchmark the responsivity, the ratio between photocurrent and incident THz irradiation power, we use an CW IMPATT diode with calibrated power as the THz excitation sources (0.1 THz). The incident THz light is focused onto the photodetector for THz photocurrent measurements (see Methods and Supplementary Section 6). Firstly, the incident power-dependent photovoltage measurement shows linear (or quadratic) relationship between the photovoltage and the incident power (or electric field)

at room temperature (Fig. 2b), consistent with the power law of the NHE rectification mechanism. In Fig. 2c, we show the responsivity of multiple TaIrTe₄ samples with different thicknesses for the same incident power (See Supplementary Section 7 for the calculation procedure). As a comparison, we also measured the THz photocurrent response of a graphene detector based on the same device geometry. Compared with the response of all TaIrTe₄ devices, the reference graphene sample shows significantly lower photovoltage. This comparison under the same device geometry and the THz photocurrent measurement setup suggests that the strong response in TaIrTe₄ should come from the NHE, which is not possible in the centrosymmetric graphene device. Moreover, a responsivity enhancement has been observed from thick layers down to bilayer (Fig. 2c). This may result from both the crystal symmetry and electronic band mixing difference at Fermi level between bulk and ultrathin samples. Note that the THz responsivity of bilayer TaIrTe₄ has achieved 0.3 A W⁻¹ without any bias or preamplifier amplification at room temperature. The value is significantly higher than that in previously studied bulk NbIrTe₄ and bulk 1T-CoTe₂ without bias^{25,26}. In bulk NbIrTe₄, the screw-axis and glide-plane symmetries are preserved to eliminate in-plane photocurrent current generation only by normal incident THz wave with in-plane driving electrical field. Thus, an additional voltage bias must be applied to induce asymmetry and promote carrier diffusion, however this also generates large dark current even without light irradiation, which significant undermine the detection sensitivity. While for 1T-CoTe₂, it is mediated by extrinsic disorder contribution and its responsivity includes additional gain from an external preamplifier. In contrast, the rectification in ultrathin TaIrTe₄ is primarily attributed to the intrinsic quantum geometrical property as verified by the scaling law analysis of nonlinear Hall response (See Supplementary Section 8), resulting in a large responsivity at room temperature. Such a large responsivity also leads to high sensitivity of our THz photodetector, giving a noise equivalent power (NEP) down to pW Hz^{-1/2} (Fig. 2d and Supplementary Section 9 for calculation procedure). This value is comparable to the top performance of room-temperature THz photodetectors such as GaN high-electron-mobility transistor (HEMT, 0.6 pW Hz^{-1/2}), and orders of magnitude better than commercialized bolometers (~ 30 -200 pW Hz^{-1/2}), Golay cells (~ 100 pW Hz^{-1/2}) and Schottky diodes (10 – 30 pW Hz^{-1/2})^{5,8}. Such high responsivity and low noise equivalent power via nonlinear Hall mechanism in the atomically thin topological semimetals can enable practical applications such as high-performance room temperature THz imaging (See Supplementary section 10 for more information).

To further investigate the NHE mechanism, we examine its anisotropic response with incident THz polarization. In Fig. 2e, we show the photovoltage response at different angles of THz polarization, from the transverse (*b* axis) to the longitudinal (*a* axis). We consistently observe a maximum photovoltage when the incident polarization angle is aligned with the *a* axis. Additionally, the photovoltage measured along the longitudinal direction (*a* axis) is significantly lower than that along the transverse direction (*b* axis). This photocurrent generation anisotropy is well aligned with the expected nonlinear Hall response in a Pm

space group crystal. Building upon the confirmation of nonlinear Hall rectification mechanism, we further investigate its potential for THz rectification at higher incident frequency (Fig. 2f and Supplementary Section 11). Surprisingly, the responsivity remains above 0.2 A W^{-1} for 3 to 10 THz with a less than 25% drop compared to the responsivity at 0.1 THz. This behavior overcomes the grand frequency cutoff challenge in conventional electronic THz rectifiers such as Schottky diodes^{9,10}, which typically only have narrow operating bandwidth ~ 0.1 THz. Such a broadband response is suspected to result from the junction-free device nature and relatively short carrier lifetime of semimetals at room temperature ($\omega\tau < 1$ and prefactor $\frac{1}{1+\omega^2\tau^2} \sim 1$). Indeed, based on Hall measurements the carrier lifetime at room temperature is only tens of femtoseconds (See Supplementary Section 12).

Besides responsivity, NEP and response bandwidth, response time is another important device metric for THz photodetectors. For the fundamental nonlinear Hall dynamics and device bandwidth characteristics, both the intrinsic and extrinsic response times need to be considered. In few-layer TaIrTe₄, the intrinsic response time represents the fundamental speed limit governed by the nonlinear rectification mechanism for photocurrent generation, while the extrinsic response time is longer and accounts for an additional bandwidth limit from photodetector circuits. In our photodetectors, we determine the intrinsic time response by ultrafast autocorrelation measurements³¹. In this configuration (Fig. 2g inset), picosecond THz pulses are generated by optical rectification of femtosecond NIR pulses in BNA organic crystals³² (See Supplementary Section 13). Each THz pulse is split up into two pulses and subsequently recombined collinearly at the device under test. The photovoltage is measured as a function of the two-pulse delay time. Given the nonlinear rectification process, a maximum enhancement of photocurrent signal is observed at zero delay (Fig. 2g). As the time delay increases, the less overlap of the two THz pulse envelopes results in a smaller interference of NHE current or voltage rectification. Finally, the measured photovoltage reaches to a constant level, where the two input THz pulses are completely separated in the time domain. By fitting the autocorrelated photocurrent data with input THz pulse convolution, we estimate an intrinsic response time on the order of ps, suggesting its great potential for high-speed applications. We also characterized the extrinsic response time of our prototype THz sensor (See Supplementary Section 14), giving a rise time of $4.2 \pm 0.4 \mu\text{s}$. Further device optimization can be implemented on the ohmic contacts, the dielectric environment and the device geometry to further reduce resistance and capacitance for achieving the intrinsically fast speed benefiting from its unique junction-free rectification feature³³.

Enhanced THz rectification by an emergent correlated charge ordering

In addition to the comprehensive THz rectification characterization at room temperature, we observed a strong temperature dependence of the THz photovoltage in ultrathin TaIrTe₄ (Fig. 3a). When

cooling from 300 K to 65 K, the responsivity exhibits only minor changes. However, upon cooling below 65 K, the responsivity dramatically increases and continues to increase down to the lowest temperatures of our setup (4 K), reaching a maximum of 13.7 A W^{-1} . Concomitantly, the absolute photovoltage is also substantially enhanced as compared to that at room temperature. Moreover, we find a nearly π phase shift in photocurrent simultaneous to the dramatic amplitude change (Fig. 3b). Given the same incident THz power and frequency, the nonlinear Hall formular suggests an abrupt change in both amplitude and sign for χ_{baa} . Furthermore, the detection sensitivity of the device is also boosted (Fig. 3c) with the NEP of the bilayer TaIrTe₄ reaching $5 \times 10^{-14} \text{ W Hz}^{-1/2}$ at 4 K, better than that of quantum well photodetectors and Si bolometers at similar temperatures^{5,8}.

To understand the origin of such a dramatic property change, we have conducted the temperature-dependent resistance measurement on another bilayer TaIrTe₄ device (Fig. 3d). Here, R represents the four-probe resistance along the crystalline a axis. Upon cooling from room temperature, the resistance decreases and can be fit by $R \sim T$, which is consistent with reduced phonon scattering in metals or semimetals³⁴. Below 100 K, the resistance dependence changes and can be fit by $R \sim T^2$. This scaling law change suggests that the sample starts to exhibit Fermi-liquid behavior due to the nontrivial electron-electron interactions^{35,36}. Further cooling down, a resistance anomaly has been observed around the transition temperature $T_C = 66$ K. This signature is more evident in dR/dT plot (Fig. 3d inset). Such a resistance anomaly has been widely recognized as a hallmark for phase transitions mediated by strong electron correlation in quantum semimetal and metals³⁷⁻³⁹. And the transition temperature is typically defined at the anomaly peak or dip positions in dR/dT plot. Indeed, such a strong electron correlation has also been observed in centrosymmetric monolayer TaIrTe₄ via quantum transport⁴⁰. Their electronic susceptibility calculations suggest a phase instability in conduction band at a nesting vector of $Q (0.068 \cdot \frac{2\pi}{a}, 0 \cdot \frac{2\pi}{b})$, connecting two neighboring van Hove singularities. This instability may lead to an electron density modulation along the one-dimensional Ta chain (a -axis), with a relatively large period of about 15 atomic unit cells. Future experimental study such as scanning tunneling microscopy would enable the direct visualization of the proposed charge density wave pattern.

Nevertheless, this emergent electron correlation could result in nontrivial band renormalization with flatten band and abundant band inversions around the Fermi level. This leads to a more drastic change of Berry curvature in momentum space with greatly enhanced $\partial_k \Omega_n(k)$, which is proportional to the strength of nonlinear Hall effect. Besides, the emergence of less dispersive bands with more density of states available around Fermi level can also promote the THz rectification response. Indeed, our calculations based on Hartree Fock method point out the introduction of electron correlation can modify the bands around Fermi level and results in Berry curvature dipole change (Supplementary Section 15). In

particular, we find that Berry curvature dipole D_{ac} can be enhanced when the electron correlation occurs. Also, the sign of the Berry curvature distribution can be flipped, consistent with the observed 180-degree phase change of the THz photocurrent after the transition.

Beyond the transport anomaly observation, such an electron correlation scenario as the emerging new state is further evinced by optical SHG and polarization-resolved THz photocurrent measurements. For the former (Fig. 3e), we observe an associated transition in the SHG intensity, which we suspect is from an increase in the electronic density of state due to band renormalization and folding. In addition, we observe a monotonic enhancement of the THz photocurrent anisotropy when the topological semimetal transitions into this new correlated state (Fig. 3f). For example, when the incident linear THz wave polarization is rotated, the b -axis photocurrent of ultrathin TaIrTe₄ shows an intensity anisotropy ratio of 14:1 (a axis: b axis incidence wave) in this new state at 4 K, about a factor of 4 larger than the room temperature value. Similar enhancement of anisotropy arises from the phase transition has also been observed in the temperature-dependent optical linear dichroism (see Supplementary Section 16).

Electrostatic gate control of the correlated charge ordering and the nonlinear THz electrodynamics

Finally, we examine how in-situ electrostatic gating can influence the correlated charge ordering and corresponding THz electrodynamics. Using a SiO₂/Si back gate in a bilayer TaIrTe₄ device, we measured the THz photocurrent response as a function of gate bias and temperature. The gate-temperature responsivity mapping shows nontrivial modulation of the phase diagram and the further enhancement of the THz responsivity (Fig. 4a, b and Supplementary Section 17). Two dome-like regions with enhanced THz photoresponsivity are observed, one at positive and the other at negative gate biases. For example, the responsivity reaches $\sim 18 \text{ A W}^{-1}$ at 4 K for a gate bias at 30 V and -100 V, respectively. A gate modulation of nonlinear Hall strength, which varies over a factor of 4, is also observed at 4 K (Fig. 4c), with its maximum value about 1.5 times at room temperature (Fig. 4d and Supplementary Section 17). Another interesting observation is the gate-controllable phase switching between the electron correlated state and the noninteracting semimetal state, resulting in on-demand modulation of THz rectification strength and photocurrent flow direction. In particular, the 2D phase mapping (Fig. 4b) clearly outlines the gate-controllable phase boundaries between a noninteracting semimetal state and the correlated electronic phase with a tunable transition temperature from 40 to 80 K. As shown in Fig. 4e, this gate controllable switching is especially visible near the pristine transition temperature, where V^{DC} completely switches sign. Thus, we demonstrate that both the nonlinear Hall strength and THz rectification current direction can be controlled on-demand (See Supplementary Section 17 for further comparison). The observed gate-dependent THz electrodynamics can be understood in the following manner: the intrinsic BCD influences on nonlinear electrodynamics are highly susceptible to the position of the Fermi level and the applied electric field. A

recent theoretical analysis highlights the Fermi level dependence for intrinsic Berry curvature, side-jump and skew scattering contributions in nonlinear Hall rectification⁴¹. Our DFT calculations also indicate the electric field, imparted by gate, can modify the Berry curvature and corresponding nonlinear Hall strength (Supplementary Section 18), showing qualitative agreement with our experimental data. Finally, the electron correlation can also be influenced by the gate bias leading to the observed gate-controlled phase transition near the intrinsic transition temperature (See Supplementary Section 17 for more details). Taken together, the band nesting and resulting flat band effects on the nonlinear Hall rectification process can be substantially modified and enhanced by applying electrostatic control, which is a unique tuning knob for 2D layered topological semimetals.

Conclusions

We have investigated the interplay between quantum geometrical properties, gate-tunable electron correlation and THz electrodynamics in atomically-thin layers of a topological semimetal, TaIrTe₄. Combined with first-principles calculations, we found the electron correlation in 2D TaIrTe₄ induces substantial band renormalization with abundant band crossings and inversions around the Fermi level, which leads to drastic changes in the Berry curvature and enhanced nonlinear Hall effect. This nonlinear Hall effect can be used for THz rectification, allowing electrical THz photodetectors to be created with a room temperature responsivity of 0.3 A W⁻¹, low NEP of ~ 1 pW Hz^{-1/2}, fast intrinsic speed (\sim ps), and broadband THz response (0.1–10 THz). Moreover, we found that the responsivity can be increased by almost a factor of 50 (to 18 A W⁻¹) and NEP of 0.05 pW Hz^{-1/2} when the topological semimetal transitions to a correlated electronic phase. The responsivity and sensitivity of few-layer TaIrTe₄ detectors show several advantages compared to current electronic-type THz detectors based on conventional technology or 2D materials (Fig. 4f). Our work advances the understanding of THz nonlinear electrodynamics in 2D correlated topological semimetals and could be used to develop high-performance THz sensing technology⁴⁷.

Methods

Single crystal synthesis

Single crystals of TaIrTe₄ were synthesized via a flux method using excess tellurium. Ta powder (99.98%), Ir powder (99.99%) and Te lumps (99.9999%) were loaded in a 1:1:20 ratio (Ta:Ir:Te) into an alumina Canfield crucible set and sealed in a quartz ampule under vacuum (5×10^{-6} Torr). The regents were then

heated to 1100 °C for over 24 hours and dwelled for 5 days, before cooling to 600 °C at 1 °C /hr. The ampule was then quickly cooled to 525 °C and centrifuged to remove excess tellurium. To remove any residual Te on the surface, the resulting single crystals were sealed in another evacuated ampule and annealed at 425 °C for 2 days with a ~200 °C temperature gradient.

THz sensing device fabrication

Multilayer hexagonal boron nitride (hBN) and few-layer TaIrTe₄ flakes were mechanically exfoliated and picked up using a dry stacking method. Then the entire hBN/TaIrTe₄ stack was transferred onto a 280 nm SiO₂/Si substrate with pre-patterned metal contacts and bow-tie antenna. All device fabrication processes are conducted within a nitrogen-filled glove box with O₂ and H₂O level less than 0.01 ppm. The thickness of the TaIrTe₄ flakes was confirmed by optical contrast and atomic force microscopy.

THz photocurrent characterization

0.1 THz CW wave is generated by an IMPATT diodes (Terasense Group Inc) with electrical trigger modulation. The modulated THz wave is routed by a set of gold parabolic mirrors, then focused onto the sample. The sample is mounted on a copper sample holder inside an optical cryostat (Cryo Industries of America, Inc) with temperature range from 4 to 500 K. The cryostat is mounted on an XYZ stage for signal optimization. After the THz signal is transformed to DC voltage by the few-layer TaIrTe₄ rectifiers, the voltage signal is then collected and analyzed by a preamplifier (Stanford Research, SR570) and a lock-in amplifier (SSI-Instrument, OE1022D). The responsivity calculation has divided the preamplifier gain to obtain the intrinsic responsivity of the device.

Ultrafast autocorrelation photocurrent measurements

We used a mode-locked Ti:Sapphire laser (Astrella, Coherent) capable of delivering 35 fs optical pulses ($\lambda_{center} = 800$ nm) at a repetition rate of 1 kHz to generate coherent THz pulses for the autocorrelation measurements. In particular, coherent THz pulses were induced through an optical rectification process via optical pumping of a pair of BNA crystals. The pair of THz pulses are subsequently recombined collinearly onto the device under test. The photovoltage is measured as a function of the two-pulse delay time. Given the nonlinear rectification process, a maximum enhancement of photocurrent signal is expected at zero delay. As the time delay increases, the less overlap of the THz pulses envelopes will result in smaller current rectification profiles interference until it reaches to a constant level, where the rise edges and fall edges of rectification currents by the two pulses are not affecting with each other. By fitting the autocorrelated photocurrent data, one can estimate an intrinsic response time determined by the distinct THz rectification

dynamics.

Nonlinear optical spectroscopy

The measurements were conducted using an optical second harmonic detection setup coupled with a cryogenic system (OptiCool, Quantum Design) capable of operating from 1.7 K to 300 K. The excitation light at 1040 nm was generated by a tunable femtosecond laser (Discover NX, Coherent Inc.). This excitation laser was linearly polarized with polarization rotating using a half waveplate and focused on the sample through a 50x NIR objective, achieving a spot size around 3 μm . The second harmonic generation (SHG) signal was detected in a backscattering configuration, transmitted through a polarizer aligned parallel to the crystal b axis and collected using photon-counting PMT modules. For the SHG polarization pattern study, a half-wave plate was used to control the polarization of the incident light, while a polarizer was employed to analyze the emitted SHG light from the sample.

First Principles Calculation

We use the Vienna ab initio simulation package (VASP)⁴⁸ to determine the most stable structure and analyze the electronic properties of TaIrTe₄. The projector-augmented-wave (PAW) pseudopotentials are utilized to describe the valence electron configurations for Ta, Ir, and Te., specifically 5p⁶ 6s² 5d⁴, 6s¹ 5d⁸, and 5s² 5p⁴, respectively. The Perdew-Burke-Ernzerhof (PBE) functional is employed to address electronic interactions. The plane waves' energy cutoff is set at 500 eV, and the Gaussian smearing method's width is chosen to be 0.05 eV. A Gamma-centered k-mesh of 16×8×1 is used for Brillouin Zone (BZ) integrations, with a spacing resolution of 0.02 $2\pi/\text{\AA}$. To achieve the ground state, the convergence criteria for lattice optimizations are set at 10^{-6} eV and 0.1 meV/ \AA for total energy and ionic forces, respectively. The optB88-vdW correlation functional is applied to account for the van der Waals (vdW) interactions. To investigate the transportation feature, we transformed the eigenstates of DFT calculations into a set of Maximally localized Wannier functions.⁴⁹

As for the NLHE, the intrinsic part of the NLH conductivity $\chi_{\alpha\beta\gamma}$ can be described by the BCD⁵⁰, which can be calculated as follows:

$$\chi_{\alpha\beta\gamma} = -\epsilon_{\alpha\beta\gamma} \frac{e^3 \tau}{2\hbar^2(1+i\omega\tau)} D_{\beta\gamma},$$

$$D_{\beta\gamma} = \int_{\mathbf{k}} f_n^0(\mathbf{k}) \frac{\partial \Omega_{\gamma}^n}{\partial k_{\beta}},$$

Where $D_{\beta\gamma}$ is the BCD, $f_n^0(\mathbf{k})$ is the equilibrium Fermi-Dirac distribution, τ is the relaxation time, $\epsilon_{\alpha\beta\gamma}$ is the third rank Levi-Civita symbol, $\alpha, \beta = a, b$ and $\gamma = c$ in 2D. The Berry curvature Ω_c in the 2D system can be calculated by⁵¹,

$$\Omega_c(\mathbf{k}) = -2Im \sum_{m \neq n} \frac{\langle n | \partial_{k_a} H | m \rangle \langle m | \partial_{k_b} | n \rangle}{(\epsilon_n - \epsilon_m)^2},$$

Where ϵ_n and $|n\rangle$ are eigenvalues and eigenvectors, respectively.

Data availability

The data that support the plots within this paper and other findings of this study are available from the corresponding author upon reasonable request. Source data are provided with this paper.

Code availability

The codes used for the calculation are available from the corresponding authors on reasonable requests.

Acknowledgement

T.X., J.R. and J.X. acknowledges primary support from the Office of Naval Research (N00014-24-1-2068). C. F. and J.X. acknowledge additional support from the U.S. National Science Foundation (DMR-2237761). Y.M., H.J. and Y.W. acknowledge support from the Department of Energy Office of Basic Energy Sciences (DE-SC0024176). J. L. and L.P. are supported by the National Science Foundation Materials Research Science and Engineering Center program through the UT Knoxville Center for Advanced Materials and Manufacturing (DMR-2309083). Y. Z. is supported by the start-up fund at University of Tennessee Knoxville. D.R. and Y.H.E. acknowledge support by the NSF through the University of Wisconsin Materials Research Science and Engineering Center (DMR-2309000). K.W. and T.T. acknowledge support from the JSPS KAKENHI (Grant Numbers 21H05233 and 23H02052) and World Premier International Research Center Initiative (WPI), MEXT, Japan. Y.G. and D.V.W. are supported by the U.S. Office of Naval Research under PANTHER award number N00014-24-1-2200 through Dr. Timothy Bentley.

Author Contributions

J.X. and T.X. conceived the research and designed the experiments. Y.W. and J.X. supervised the project. Y.H. synthesized the bulk high-quality TaIrTe₄ crystals under the guidance of D.R.; T.T. and K.W. provided the high-quality h-BN bulk crystals. Y.G. designed the THz sensing device with H.J. and T.X., under the guidance of D.V.W., Y.W. and J.X.; H. J., C.F., T.X. and Y.M. fabricated the devices under the guidance of Y.W. and J.X.; T.X. performed the THz photocurrent and SHG measurements and analyzed the data with J.X.; J.R. conducted the AFM measurements under the guidance of J.X.; J. Li. , L. P. and Y. Z. performed first-principles and Hartree-Fock calculations. All authors discussed the results and jointly wrote

the paper.

Competing interests

J.X. Y.W. and D.V.W. have submitted a patent application ('Terahertz radiation detectors based on thin films of non- centrosymmetric layered topological semimetals'; US no. 18/448,648) that covers a specific aspect of the manuscript. The other authors declare no competing interests.

Figure Legends/Captions

Figure. 1: Large nonlinear Hall effect in few-layer TaIrTe₄ at room temperature. **a**, Top and side views of the crystal structure of few-layer TaIrTe₄. The lack of the screw-axis and glide-plane symmetries at few-layer limit allows an in-plane polar axis along the mirror line for nontrivial in-plane nonlinear Hall effect. **b**, Polarization-resolved second harmonic generation (SHG) of a four-layer TaIrTe₄, whose pattern fits well to Pm space group. Here only the incident light polarization is rotating. 0 degree refers to the polarization aligned with crystal *b* axis, and it is also the fixed SHG detection polarization direction. **c**, The nonlinear hall transport measurement of a bilayer TaIrTe₄ at 300K. Second-harmonic transverse voltage $V^{2\omega}$ in response to an applied a.c. I^ω along crystalline *a* axis, shows quadratic power law and large second-order nonlinear conductivity χ_{baa} about $0.1 \mu\text{m V}^{-1} \Omega^{-1}$, which is about three orders of magnitude than that in bulk TaIrTe₄³⁰. The inset is the schematics of a Hall bar device and measurement configuration. **d**, Calculated local Berry curvature dipole distribution $D_{ac} = D_{xz} = \partial_{k_x} \Omega_z(k)$ in the two-dimensional Brillion zone at $E=E_F + 0.02 \text{ eV}$ for bilayer TaIrTe₄. Here k_x is along the *a* axis in the calculations. The Berry curvature dipole unit here is Å.

Figure. 2: Room-temperature THz rectification in few-layer TaIrTe₄ topological semimetals.

a, Schematics for a new THz sensing mechanism in 2D topological semimetal TaIrTe₄. In particular, large nonlinear Hall effect efficiently rectifies THz wave to DC voltage mediated by the diverging Berry curvature in layered topological semimetals. Photovoltage is maximized along the *b*-axis with incident THz electric field along the *a*-axis. The resulting THz photodetector may enable sensitive, broadband, and ultrafast THz wave detection. **b**, Incident THz fluence dependent photovoltage. It shows linear (or quadratic) relationship between the photovoltage and the incident power (or electric field). Error bars of black circles (mean) represent standard deviations result from $n = 1,000$ random samplings at each data point. The inset shows the typical THz sensor based on few-layer TaIrTe₄ (cyan flake) covered by thin h-BN (sapphire blue flake), the scale bar is $10 \mu\text{m}$. **c**, Photovoltage response comparison of few-layer TaIrTe₄ with various thickness and reference graphene sample. **d**, Noise equivalent power (NEP) characterization of a bilayer TaIrTe₄ THz sensing device shows superior sensitivity at room temperature. **e**, THz polarization dependence of photovoltage measured along *a* and *b* axis. The legends in the figure (a and b) represent along which crystalline direction the photocurrent is measured. The horizontal axis represents the incident THz wave polarization direction,

the 0 degree refers to the polarization aligned parallel to the crystalline b axis. The signal variation is consistent with underlying nonlinear Hall rectification mechanism with certain Pm space group symmetry constraint. **f**, Broadband THz response characterization of a bilayer TaIrTe₄ device. It shows large responsivity over the entire THz regime from 0.1 to 10 THz before suffering significant cut-off. Broadband blackbody radiation source and THz filters are used (see Supplementary Section 11 for more details). Error bars represent standard deviations result from $n = 2,000$ random samplings at each data point. **g**, Intrinsic response time characterization by ultrafast autocorrelation measurements, suggesting an ultrafast rectification response down to picosecond level. The inset shows the pulsed autocorrelation measurement schematics.

Figure. 3: Enhanced THz electrodynamics by correlated charge ordering in few-layer TaIrTe₄.

a, Temperature dependent THz responsivity of a bilayer TaIrTe₄ device. A dramatic enhancement of THz rectification is observed below a critical transition temperature ($T_c \sim 66$ K). **b**, Temperature dependent THz photovoltage phase of the same device. Below the T_c , a synchronized π phase shift is observed, suggesting a sign change in intrinsic Berry curvature dipole and corresponding nonlinear Hall rectification. **c**, NEP characterization after the transition shows greatly enhanced THz sensitivity performance down to $50 \text{ fW Hz}^{-1/2}$. **d**, Temperature dependent resistance in a bilayer TaIrTe₄ device. Here R represents the four-probe resistance along the a axis. Upon cooling below 100 K, the sample starts to show Fermi liquid behavior ($R \sim T^2$) associated with electron-electron interaction. A resistance anomaly is observed around the transition temperature ~ 66 K, which is more evident in the dR/dT plot (Fig. 3d inset). **e**, Temperature dependent second harmonic generation (SHG) of a few-layer TaIrTe₄. SHG intensity increases is found below the transition temperature. The incident light polarization is fixed along crystalline axis b , with no polarizer inserted for detection. Error bars of black rectangle represent standard deviations result from random samplings with gate number of 100 collected by PMT. **f**, Incident THz polarization dependent photovoltage at varying temperature. The angle in the horizontal axis represents the incident THz wave polarization direction with 0 degree defined as the polarization parallel to the crystalline b axis. The photovoltages are normalized by the values measured at 0 degree. Also, all photovoltages here are collected along the crystalline b axis. Error bars of circles represent standard deviations result from $n = 1,000$ random samplings.

Figure. 4: Electrostatic gate control of electron correlation and THz rectification

a, Mapping of THz rectification responsivity as a function of gate bias and temperature. **b**, Corresponding mapping of THz rectification voltage phase. **c**, **d**, Single gate modulation of THz photovoltage at 4K and 300K, respectively. **e**, Gate control of phase transitions and THz photovoltage flip at 66 K. **f**, THz sensing performance comparison among electronic-type detectors based on different 2D layered materials and conventional THz rectifiers with zero source-drain bias to avoid large dark current. BP: black phosphorous⁴², QW: quantum well⁴³, SD: Schottky diode¹⁰. The data points of Bi₂Se₃, PdTe₂ and graphene are adapted from the literature^{44–46}.

Reference

1. Sengupta, K., Nagatsuma, T. & Mittleman, D. M. Terahertz integrated electronic and hybrid electronic–photonic systems. *Nature Electronics* vol. 1 Preprint at <https://doi.org/10.1038/s41928-018-0173-2> (2018).
2. Damari, R. *et al.* Strong coupling of collective intermolecular vibrations in organic materials at terahertz frequencies. *Nat Commun* **10**, (2019).
3. Gomonay, O., Baltz, V., Brataas, A. & Tserkovnyak, Y. Antiferromagnetic spin textures and dynamics. *Nature Physics* vol. 14 Preprint at <https://doi.org/10.1038/s41567-018-0049-4> (2018).
4. Dang, S., Amin, O., Shihada, B. & Alouini, M. S. What should 6G be? *Nat Electron* **3**, (2020).
5. Lewis, R. A. A review of terahertz detectors. *Journal of Physics D: Applied Physics* vol. 52 Preprint at <https://doi.org/10.1088/1361-6463/ab31d5> (2019).
6. Valušis, G., Lisauskas, A., Yuan, H., Knap, W. & Roskos, H. G. Roadmap of terahertz imaging 2021. *Sensors* vol. 21 Preprint at <https://doi.org/10.3390/s21124092> (2021).
7. Yachmenev, A. E., Khabibullin, R. A. & Ponomarev, D. S. Recent advances in THz detectors based on semiconductor structures with quantum confinement: a review. *J Phys D Appl Phys* **55**, 193001 (2022).
8. Rogalski, A. Progress in performance development of room temperature direct terahertz detectors. *Journal of Infrared, Millimeter, and Terahertz Waves* vol. 43 Preprint at <https://doi.org/10.1007/s10762-022-00882-2> (2022).
9. Hesler, J. L. & Crowe, T. W. NEP and responsivity of THz zero-bias Schottky diode detectors. in *IRMMW-THz2007 - Conference Digest of the Joint 32nd International Conference on Infrared and Millimetre Waves, and 15th International Conference on Terahertz Electronics* (2007). doi:10.1109/icimw.2007.4516758.
10. Yadav, R. *et al.* State-of-the-Art Room Temperature Operable Zero-Bias Schottky Diode-Based Terahertz Detector Up to 5.56 THz. *Sensors* 2023, Vol. 23, Page 3469 **23**, 3469 (2023).
11. Shen, Y. *et al.* Nonlinear photocurrent in quantum materials for broadband photodetection. (2024).
12. Wang, Q. *et al.* Robust edge photocurrent response on layered type II Weyl semimetal WTe₂. *Nat Commun* **10**, (2019).
13. Ma, J. *et al.* Nonlinear photoresponse of type-II Weyl semimetals. *Nat Mater* **18**, (2019).
14. Kang, K., Li, T., Sohn, E., Shan, J. & Mak, K. F. Nonlinear anomalous Hall effect in few-layer WTe₂. *Nature Materials* Preprint at <https://doi.org/10.1038/s41563-019-0294-7> (2019).
15. Ma, Q. *et al.* Observation of the nonlinear Hall effect under time-reversal-symmetric conditions. *Nature* (2019) doi:10.1038/s41586-018-0807-6.

16. Xiao, J. *et al.* Berry curvature memory through electrically driven stacking transitions. *Nat Phys* **16**, 1028–1034 (2020).
17. Kumar, D. *et al.* Room-temperature nonlinear Hall effect and wireless radiofrequency rectification in Weyl semimetal TaIrTe₄. *Nat Nanotechnol* **16**, 421–425 (2021).
18. Sodemann, I. & Fu, L. Quantum Nonlinear Hall Effect Induced by Berry Curvature Dipole in Time-Reversal Invariant Materials. *Phys Rev Lett* **115**, 216806 (2015).
19. Du, Z. Z., Wang, C. M., Sun, H.-P., Lu, H.-Z. & Xie, X. C. Quantum theory of the nonlinear Hall effect. *Nat Commun* **12**, 5038 (2021).
20. Tiwari, A. *et al.* Giant c-axis nonlinear anomalous Hall effect in Td-MoTe₂ and WTe₂. *Nat Commun* **12**, (2021).
21. Ma, Q. *et al.* Observation of the nonlinear Hall effect under time-reversal-symmetric conditions. *Nature* **565**, 337–342 (2019).
22. Boyd, G. D. & Pollack, M. A. Microwave Nonlinearities in Anisotropic Dielectrics and Their Relation to Optical and Electro-Optical Nonlinearities. *Phys Rev B* **7**, 5345 (1973).
23. Bortz, M. L., Eyres, L. A. & Fejer, M. M. Depth profiling of the d₃₃ nonlinear coefficient in annealed proton exchanged LiNbO₃ waveguides. *Appl Phys Lett* **62**, 2012–2014 (1993).
24. Zhang, Y. & Fu, L. Terahertz detection based on nonlinear Hall effect without magnetic field. *Proc Natl Acad Sci U S A* **118**, (2021).
25. Zhang, J. *et al.* Colossal Room-Temperature Terahertz Topological Response in Type-II Weyl Semimetal NbIrTe₄. *Advanced Materials* **34**, 2204621 (2022).
26. Hu, Z. *et al.* Terahertz Nonlinear Hall Rectifiers Based on Spin-Polarized Topological Electronic States in 1T-CoTe₂. *Advanced Materials* **35**, 2209557 (2023).
27. Belopolski, I. *et al.* Signatures of a time-reversal symmetric Weyl semimetal with only four Weyl points. *Nature Communications* **2017 8:1** **8**, 1–7 (2017).
28. Xiao, J. *et al.* Berry curvature memory through electrically driven stacking transitions. *Nat Phys* **16**, 1028–1034 (2020).
29. Kang, K., Li, T., Sohn, E., Shan, J. & Mak, K. F. Nonlinear anomalous Hall effect in few-layer WTe₂. *Nat Mater* **18**, 324–328 (2019).
30. Kumar, D. *et al.* Room-temperature nonlinear Hall effect and wireless radiofrequency rectification in Weyl semimetal TaIrTe₄. *Nat Nanotechnol* **16**, (2021).
31. Sun, D. *et al.* Ultrafast hot-carrier-dominated photocurrent in graphene. *Nature Nanotechnology* **2011 7:2** **7**, 114–118 (2012).
32. Zaccardi, Z. B. *et al.* Enabling high-power, broadband THz generation with 800-nm pump wavelength. *Optics Express, Vol. 29, Issue 23, pp. 38084–38094* **29**, 38084–38094 (2021).

33. Yoshioka, K. *et al.* On-chip transfer of ultrashort graphene plasmon wave packets using terahertz electronics. *Nature Electronics* 2024 7:7 7, 537–544 (2024).
34. Hwang, E. H. & Das Sarma, S. Linear-in-T resistivity in dilute metals: A Fermi liquid perspective. *Phys Rev B* **99**, 085105 (2019).
35. Palstra, T. T. M., Hebard, A. F., Haddon, R. C. & Littlewood, P. B. Fermi-liquid behavior in the electrical resistivity of K₃C₆₀ and Rb₃C₆₀. *Phys Rev B* **50**, (1994).
36. Grissonnanche, G. *et al.* Linear-in temperature resistivity from an isotropic Planckian scattering rate. *Nature* 2021 595:7869 **595**, 667–672 (2021).
37. Shen, B. *et al.* Strange-metal behaviour in a pure ferromagnetic Kondo lattice. *Nature* 2020 579:7797 **579**, 51–55 (2020).
38. Bhoi, D. *et al.* Interplay of charge density wave and multiband superconductivity in 2H-PdxTaSe₂. *Scientific Reports* 2016 6:1 **6**, 1–10 (2016).
39. Liao, M. *et al.* Coexistence of resistance oscillations and the anomalous metal phase in a lithium intercalated TiSe₂ superconductor. *Nature Communications* 2021 12:1 **12**, 1–7 (2021).
40. Tang, J. *et al.* Dual quantum spin Hall insulator by density-tuned correlations in TaIrTe₄. *Nature* 2024 628:8008 **628**, 515–521 (2024).
41. Du, Z. Z., Wang, C. M., Li, S., Lu, H. Z. & Xie, X. C. Disorder-induced nonlinear Hall effect with time-reversal symmetry. *Nat Commun* (2019) doi:10.1038/s41467-019-10941-3.
42. Viti, L. *et al.* Black Phosphorus Terahertz Photodetectors. *Advanced Materials* **27**, 5567–5572 (2015).
43. Westlund, A. *et al.* Terahertz detection in zero-bias InAs self-switching diodes at room temperature. *Appl Phys Lett* **103**, 133504 (2013).
44. Viti, L. *et al.* Plasma-Wave Terahertz Detection Mediated by Topological Insulators Surface States. *Nano Lett* **16**, 80–87 (2016).
45. Guo, C. *et al.* Anisotropic ultrasensitive PdTe₂-based phototransistor for room-temperature long-wavelength detection. *Sci Adv* **6**, (2020).
46. Auton, G. *et al.* Terahertz Detection and Imaging Using Graphene Ballistic Rectifiers. *Nano Lett* **17**, 7015–7020 (2017).
47. Ma, C. *et al.* Intelligent infrared sensing enabled by tunable moiré quantum geometry. *Nature* 2022 604:7905 **604**, 266–272 (2022).
48. Kresse, G. & Hafner, J. *Ab initio* molecular dynamics for liquid metals. *Phys Rev B* **47**, 558 (1993).
49. On the theory of superconductivity: the one-dimensional case. *Proc R Soc Lond A Math Phys Sci* **223**, 296–305 (1954).

50. Zhang, Y., Sun, Y. & Yan, B. Berry curvature dipole in Weyl semimetal materials: An ab initio study. *Phys Rev B* **97**, 041101 (2018).
51. Sundaram, G. & Niu, Q. Wave-packet dynamics in slowly perturbed crystals: Gradient corrections and Berry-phase effects. *Phys Rev B* **59**, 14915 (1999).